Half Day Short Course



A03. Introduction to Inductively Coupled Plasma Mass Spectrometry (ICPMS)

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Fundamental Aspects of ICPMS

 Ion Source Characteristics
 Mass Spectrometer Types
 Operating Conditions
 Figures or Merit

Sample Introduction
 Solution-based
 Solid Sampling

3. Method Development
Spectral Interferences
Matrix Effects
Data Acquisition

Details

Instructor Dr. Bodo Hattendorf ETH Zurich

ETH ZUIICH

Date 27 August 2023

Time 13:30–16:30 h

Duration 3 h plus coffee break

Location CICG Geneva

Fees 130 CHF (delegate)

80 CHF (student)

Included Coffee break

If booking 2 courses: lunch

Instructor



Dr. B. Hattendorf

Dr. Bodo Hattendorf is a senior scientist in the Group for Trace Element and Microanalysis at ETH Zurich.

He has 25+ years of experience in ICPMS-related instrument and method development in industry and academia.

His research interests span from instrumental developments to establishing novel applications for real world analytical problems. His experience covers all sorts of mass spectrometer types (quadrupole, sector field, time of flight and recent MS/MS technology) and various sample introduction techniques including laser ablation and single micro-droplet introduction approaches.

He has taught various short courses in (LA-) ICPMS and serves as regular instructor for ICPMS in the continuing education program of the Swiss Chemical Society.